

**Notice of References Cited**

Application/Control No.

10/509,616

Applicant(s)/Patent Under  
Reexamination  
TAKAHASHI ET AL.

Examiner

Alain L. Bashore

Art Unit

1792

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,519,121	02-2003	Gill, Hardayal Singh	360/324.11
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Partial English Machine translation of JP 2002-25032; JPO; 2009; 15 pages.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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